DECEMBER 1983-REVISED MARCH 1988

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

#### description

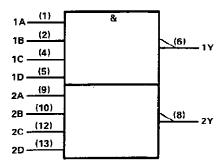
These devices contain two independent 4-input NAND gates.

The SN5420, SN54LS20, and SN54S20 are characterized for operation over the full military range of  $-55\,^{\circ}\text{C}$  to 125 °C. The SN7420, SN74LS20, and SN74S20 are characterized for operation from 0 °C to 70 °C.

#### FUNCTION TABLE (each gate)

	INP	UTS		QUTPUT
A	В	С	D	Υ
н	Н	Н	н	Ļ
L	х	X	X	Н
х	L	X	x	Н
Х	Х	L.	×	н
Х	X	Х	ᆸ	н

## logic symbol<sup>†</sup>



 $<sup>^{\</sup>dagger}\text{This}$  symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

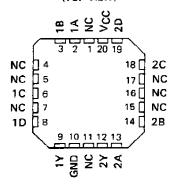
SN5420 . . . J PACKAGE
SN54LS20, SN54S20 . . . J OR W PACKAGE
SN7420 . . . N PACKAGE
SN74LS20, SN74S20 . . . D OR N PACKAGE
(TOP VIEW)

	_		
1A	П	U 14	Vcc
1 B	□2	13	2D
NC	□3	12	2C
1 C	□4	11	NC
1 D	₫5	10	2B
1Y	₫6	9	2A
<b>GND</b>	ď۶	8	2Y

# SN5420 . . . W PACKAGE (TOP VIEW)

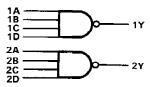
1A	Ф	U 14	þ	1D
1Y	$\Box$ 2	13		1C
NC	<b>口</b> 3	12	Þ	1 B
VCC.	<b>4</b>	11	þ	GND
NC	□5	10		2Y
2A	<b>□</b> 6	9		2D
2B	ď۶	8	Þ	2C

# SN54LS20, SN54S20 . . . FK PACKAGE (TOP VIEW)



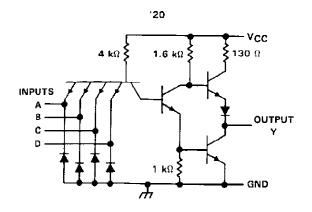
NC - No internal connection

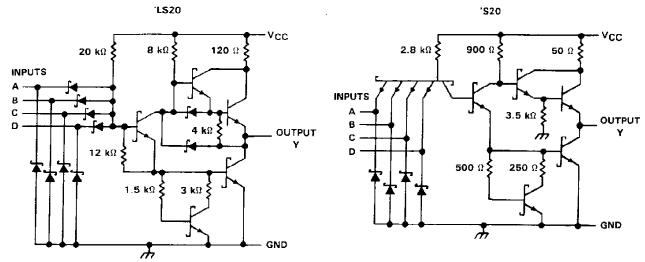
#### logic diagram



positive logic  $Y = \overline{A \cdot B \cdot C \cdot D}$  or  $Y = \overline{A} + \overline{B} + \overline{C} + \overline{D}$ 

schematics (each gate)





Resistor values shown are nominal.

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)	,,,,,,,	7 V
Input voltage: '20, 'S20		<b>5.</b> 5 V
'LS20	***************	7 V
Operating free-air temperature range:	SN54'	55°C to 125°C
	SN74'	. 0°C to 70°C
Storage temperature range		35°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminals.



#### recommended operating conditions

			SN5420			SN7420			
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	٧	
VIH	High-level input voltage	2			2			V	
VIL	Low-level input voltage			0.8			8.0	v	
lон	High-level output current			- 0.4			- 0.4	mΑ	
loL	Low-level output current			16			16	mΑ	
TA	Operating free-air temperature	- 55		125	0		70	°c	

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	****	TEST CONDITIONS †		\$N5420			SN742	0	UNIT
PARAMETER	TEST CONDITIONS I		MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
۷ıĸ	V <sub>CC</sub> = MIN, 11 = -	- 12 mA			<b>– 1.5</b>			1.5	V
Voн	V <sub>CC</sub> = MIN, V <sub>IL</sub>	= 0.8 V, I <sub>OH</sub> = - 0.4 mA	2.4	3.4		2.4	3.4		٧
VOL	VCC = MIN, VIH	= 2 V, l <sub>OL</sub> = 16 mA		0.2	0.4		0.2	0.4	٧
Ŋ	V <sub>CC</sub> - MAX, V <sub>I</sub> -	5.5 V			1		_	1	mΑ
<sup>I</sup> IH	V <sub>CC</sub> = MAX, V <sub>I</sub> =	2.4 V			40			40	μА
I <sub>I</sub> L	VCC = MAX, VI =	0.4 V			- 1.6			- 1.6	mΑ
los§	V <sub>CC</sub> = MAX	·	- 20	-	<b>– 55</b>	_ 18		- 55	mA
ССН	V <sub>CC</sub> = MAX, V <sub>I</sub> =	0 V		2	4		2	4	mA
ICCL.	V <sub>CC</sub> = MAX, V <sub>I</sub> =	4.5 V		6	11		6	11	mA

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. ‡ All typical values are at  $V_{CC}$  = 5 V,  $T_{A}$  = 25°C. § Not more than one output should be shorted at a time.

# switching characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CON	IDITIONS	MIN	TYP	мах	UNIT
<sup>†</sup> PLH	<b>A</b>	V	2 400 0	0 45 5		12	22	ns
ŧРНL	Any	Y	R <sub>L</sub> = 400 Ω,	C <sub>L</sub> = 15 pF		8	15	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

## SN54LS20, SN74LS20 DUAL 4-INPUT POSITIVE-NAND GATES

## recommended operating conditions

		SN54LS20			SN74LS20			
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
VCC Supply voltage	4.5	5	5.5	4.75	5	5.25	٧	
V <sub>IH</sub> High-level input voltage	2			2			٧	
V <sub> L</sub> Low-level input voltage			0.7			0.8	V	
IOH High-level output current			- 0.4			- 0.4	mΑ	
IOL Low-level output current			4			8	mΑ	
TA Operating free-air temperature	- 55		125	0		70	°c	

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDI	TIONS T		SN54LS	320		SN74L	S20	UNIT
FARAMETER		TEST CONDI	110145 1	MIN	TYP‡	мах	MIN	TYP‡	MAX	
VIK	VCC = MIN,	i <sub> </sub> = – 18 mA	-			<b>–</b> 1.5			<b>– 1.5</b>	V
v <sub>он</sub>	V <sub>CC</sub> = MIN,	VIL = MAX,	I <sub>OH</sub> = - 0.4 mA	2.5	3,4		2.7	3.4		v
\f_	V <sub>CC</sub> = MIN,	V <sub>IH</sub> = 2 V,	loL = 4 mA		0.25	0.4			0.4	
VOL	V <sub>CC</sub> = MIN,	V <sub>IH</sub> = 2 V,	IOL = 8 mA					0.25	0.5	<b>'</b>
11	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 7 V				0.1			0.1	mA
ĮіН	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 2.7 V				20			20	μА
IIL	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 0.4 V				- 0.4		<del></del>	- 0.4	mΑ
IOS§	V <sub>CC</sub> = MAX	•	· · · · · · · · · · · · · · · · · · ·	- 20		- 100	- 20		- 100	mΑ
Іссн	V <sub>CC</sub> = MAX,	V  = 0 V			0.4	0.8		0.4	8.0	mA
CCL	V <sub>CC</sub> = MAX,	V <sub>j</sub> = 4.5 V			1.2	2.2		1.2	2.2	mA

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

# switching characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS			TYP	MAX	UNIT
tPLH .	Апу	<b>&gt;</b>	$R_1 = 2 k\Omega$ ,	C: -15 nF		9	15	ns
<sup>‡</sup> PHL	Ally	<u>.</u>	11 - 2 Kaz,	CL = 15 pF		10	15	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

<sup>‡</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_{\Delta} = 25^{\circ}\text{C}$ .

<sup>§</sup> Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed one second.

## recommended operating conditions

	SN	SN54S20			SN74S20		
	MIN 1	NOM	MAX	MIN	NOM	MAX	UNIT
V <sub>CC</sub> Supply voltage	4.5	5	5.5	4.75	5	5.25	٧
VIH High-level input voltage	2			2			٧
VIL Low-level input voltage			8.0			0.8	V
OH High-level output current			- 1			- 1	mΑ
IOL Low-level output current			20			20	mΑ
TA Operating free-air temperature	<b>– 55</b>		125	0		70	ပ

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

0.00.000	TEST CONDITIONS †	SN54S20	SN74S20	UNIT
PARAMETER	TEST CONDITIONS I	MIN TYP# MAX	MIN TYP# MAX	UNII
Vik	V <sub>CC</sub> = MIN, I <sub>1</sub> = -18 mA	-1.2	-1.2	٧
∨он	V <sub>CC</sub> = MIN, V <sub>IL</sub> = 0.8 V, I <sub>OH</sub> = -1 mA	2.5 3.4	2.7 3.4	٧
V <sub>OL</sub>	V <sub>CC</sub> = MIN, V <sub>1H</sub> = 2 V, I <sub>OL</sub> = 20 mA	0,5	0.5	V
I <sub>I</sub>	V <sub>CC</sub> = MAX, V <sub>1</sub> = 5.5 V	1	1	mА
IIH	V <sub>CC</sub> = MAX, V <sub>1</sub> = 2.7 V	50	50	μΑ
I <sub>I</sub> L	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.5 V	-2	2	mΑ
IOS§	V <sub>CC</sub> = MAX	-40 -100	-40 -100	mA
<sup>1</sup> ссн	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0 V	5 8	5 8	mA
ICCL	V <sub>CC</sub> = MAX, V <sub>1</sub> = 4.5 V	10 18	10 18	mΑ

# switching characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	TYP	МАХ	UNIT
tpLH	A, B, C or D	Y	RL = 280 Ω,	C <sub>L</sub> = 15 pF		3	4.5	п\$
tPHL						3	5	ns,
tpLH			R <sub>L</sub> = 280 Ω,	C <sub>L</sub> = 50 pF		4.5		ns
<sup>t</sup> PHL						5		ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. ‡ All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ . § Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed one second.

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